Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/523,030	MIYA ET AL
	Examiner	Art Unit
	Tran N. Nguyen	2834

SEARCHED			
Class	Subclass	Date	Examiner
310	90.5	8/16/07	TNN
	156.08		
	156.12		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
update class/subs image search	1/28/08	TNN